1. General description

Automotive qualified N-channel MOSFET using the latest Trench 9 low ohmic superjunction technology, housed in an enhanced LFPAK56E package. This product has been fully designed and qualified to meet AEC-Q101 requirements delivering high performance and endurance.

2. Features and benefits

- Fully automotive qualified to AEC-Q101:
 - 175 °C rating suitable for thermally demanding environments
- · Trench 9 Superjunction technology:
 - Reduced cell pitch enables enhanced power density and efficiency with lower $R_{\mbox{\scriptsize DSon}}$ in same footprint
 - Improved SOA and avalanche capability compared to standard TrenchMOS
 - Tight V_{GS(th)} limits enable easy paralleling of MOSFETs
- · LFPAK Gull Wing leads:
 - High Board Level Reliability absorbing mechanical stress during thermal cycling, unlike traditional QFN packages
 - Visual (AOI) soldering inspection, no need for expensive x-ray equipment
 - · Easy solder wetting for good mechanical solder joint
- LFPAK copper clip technology:
 - Improved reliability, with reduced R_{th} and R_{DSon}
 - · Increases maximum current capability and improved current spreading

3. Applications

- 12 V automotive systems
- Motors, lamps and solenoid control
- · Start-Stop micro-hybrid applications
- Transmission control
- Ultra high performance power switching

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	-	40	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	-	220	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	-	500	W



N-channel 40 V, 0.9 m Ω logic level MOSFET in LFPAK56E

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static characte	Static characteristics						
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C; Fig. 11		0.53	0.76	0.9	mΩ
Dynamic chara	Dynamic characteristics						
Q_{GD}	gate-drain charge	I _D = 25 A; V _{DS} = 20 V; V _{GS} = 4.5 V; Fig. 13; Fig. 14		-	12.7	25.3	nC
Source-drain o	liode				•		
Q _r	recovered charge	I_S = 25 A; dI_S/dt = -100 A/ μ s; V_{GS} = 0 V; V_{DS} = 20 V; T_j = 25 °C		-	52.6	-	nC
S	softness factor	$I_S = 25 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V}; V_{DS} = 20 \text{ V}; T_j = 25 ^{\circ}\text{C}; Fig. 17$		-	0.77	-	

^{[1] 220}A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		D
2	S	source		
3	S	source		G—(F)
4	G	gate		mbb076 S
mb	D	mounting base; connected to drain	1 2 3 4 LFPAK56E; Power- SO8 (SOT1023)	

6. Ordering information

Table 3. Ordering information

Type number	number Package					
	Name	Description	Version			
BUK9J0R9-40H	LFPAK56E; Power-SO8	plastic, single-ended surface-mounted package (LFPAK56); 4 leads; 1.27 mm pitch	SOT1023			

7. Marking

Table 4. Marking codes

Type number	Marking code
BUK9J0R9-40H	90H940E

N-channel 40 V, 0.9 m Ω logic level MOSFET in LFPAK56E

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	40	V
V _{GS}	gate-source voltage	DC; T _j ≤ 175 °C		-10	16	V
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	500	W
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	220	Α
		V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 2</u>	[1]	-	220	Α
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 \text{ °C}$; Fig. 3		-	600	Α
T _{stg}	storage temperature			-55	175	°C
T _j	junction temperature			-55	175	°C
Source-drain d	iode				'	
I _S	source current	T _{mb} = 25 °C	[2]	-	165	Α
I _{SM}	peak source current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 ^{\circ}C$		-	600	Α
Avalanche rugg	gedness	•	•	•		•
E _{DS(AL)S}	non-repetitive drain- source avalanche energy	I_D = 160 A; $V_{sup} \le 40$ V; R_{GS} = 50 Ω; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped; Fig. 4	[3] [4]	-	290	mJ

 ²²⁰A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

^{[2] 165}A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

^[3] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.

^[4] Refer to application note AN10273 for further information.

N-channel 40 V, 0.9 mΩ logic level MOSFET in LFPAK56E

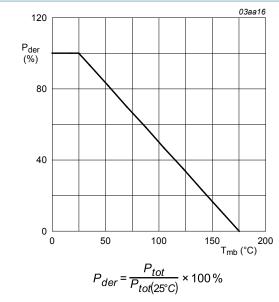
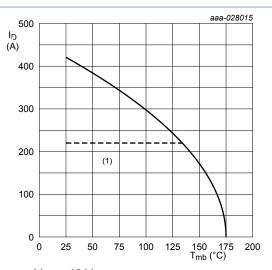
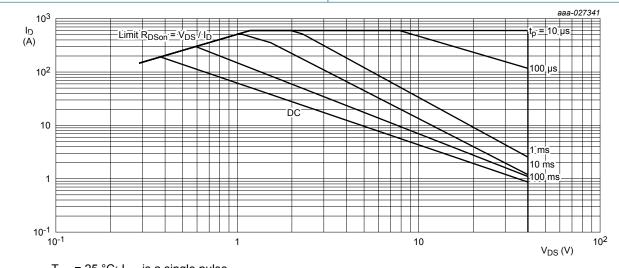


Fig. 1. Normalized total power dissipation as a function of mounting base temperature



V_{GS} ≥ 10 V (1) 220A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

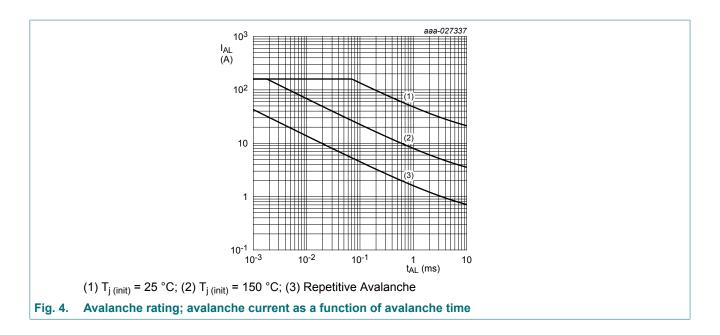
Fig. 2. Continuous drain current as a function of mounting base temperature



 T_{mb} = 25 °C; I_{DM} is a single pulse

Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

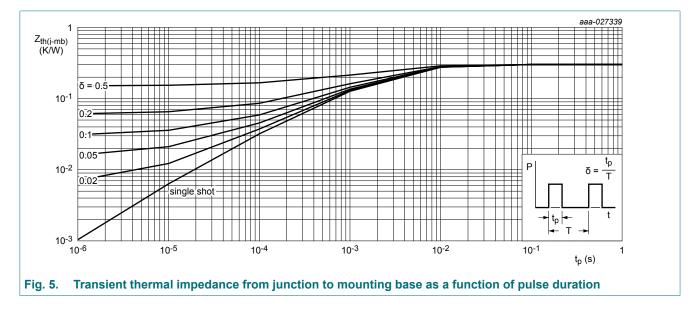
N-channel 40 V, 0.9 m Ω logic level MOSFET in LFPAK56E



9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	0.21	0.3	K/W



N-channel 40 V, 0.9 m Ω logic level MOSFET in LFPAK56E

10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics		-			
V _{(BR)DSS}	drain-source	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	40	43	-	V
	breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = -40 °C	-	40.5	-	V
		I _D = 250 μA; V _{GS} = 0 V; T _j = -55 °C	36	40	-	V
V _{GS(th)}	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C; <u>Fig. 9</u> ; <u>Fig. 10</u>	1.35	1.66	2.05	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 175 °C; Fig. 10	0.6	-	-	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = -55 °C; Fig. 10	-	-	2.5	V
I _{DSS}		5	μΑ			
		V _{DS} = 16 V; V _{GS} = 0 V; T _j = 125 °C	-	3.2	25	μA
		V _{DS} = 40 V; V _{GS} = 0 V; T _j = 175 °C	-	405	1000	μA
I _{GSS}	gate leakage current	V _{GS} = 16 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
		V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
R _{DSon}			0.53	0.76	0.9	mΩ
			0.79	1.17	1.41	mΩ
			0.87	1.29	1.57	mΩ
			1.1	1.63	1.96	mΩ
		1	0.68	0.97	1.2	mΩ
		,	1	1.47	1.9	mΩ
		,	1.1	1.62	2.1	mΩ
			1.4	2.03	2.6	mΩ
R_G	gate resistance	f = 1 MHz; T _j = 25 °C	0.42	1.04	2.6	mΩ
Dynamic ch	naracteristics					
Q _{G(tot)}	total gate charge	I _D = 25 A; V _{DS} = 20 V; V _{GS} = 10 V; Fig. 13; Fig. 14	-	120	168	nC
		I _D = 25 A; V _{DS} = 20 V; V _{GS} = 4.5 V;	-	54.2	76	nC
Q_{GS}	gate-source charge	Fig. 13; Fig. 14	-	20.2	30.2	nC
Q_{GD}	gate-drain charge		_	12.7	25.3	nC

N-channel 40 V, 0.9 m Ω logic level MOSFET in LFPAK56E

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
C _{iss}	input capacitance	Conditions $V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_{j} = 25 \text{ °C}; Fig. 15$ $V_{DS} = 20 \text{ V}; R_{L} = 0.8 \Omega; V_{GS} = 4.5 \text{ V};$ $R_{G(ext)} = 5 \Omega$ $I_{S} = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_{j} = 25 \text{ °C}; Fig. 16$ $I_{S} = 25 \text{ A}; dI_{S}/dt = -100 \text{ A/μs}; V_{GS} = 0 \text{ V};$ $V_{DS} = 20 \text{ V}; T_{j} = 25 \text{ °C}$ $I_{S} = 25 \text{ A}; dI_{S}/dt = -100 \text{ A/μs}; V_{GS} = 0 \text{ V};$ $V_{DS} = 20 \text{ V}; T_{j} = 25 \text{ °C}; Fig. 17$ $I_{S} = 25 \text{ A}; dI_{S}/dt = -500 \text{ A/μs}; V_{GS} = 0 \text{ V};$ $V_{DS} = 20 \text{ V}; T_{j} = 25 \text{ °C}; Fig. 17$	-	8977	12568	pF
C _{oss}	output capacitance		-	1549	2168	pF
C _{rss}	reverse transfer capacitance		-	346	760	pF
t _{d(on)}	turn-on delay time		-	45.4	-	ns
t _r	rise time		-	46.2	-	ns
t _{d(off)}	turn-off delay time		-	59.2	-	ns
t _f	fall time		-	32.6	-	ns
Source-dra	in diode		'			
V _{SD}	source-drain voltage	I _S = 25 A; V _{GS} = 0 V; T _j = 25 °C; <u>Fig. 16</u>	-	0.76	1.2	V
t _{rr}	reverse recovery time		-	44.6	-	ns
Q _r	recovered charge	V _{DS} = 20 V; T _j = 25 °C	-	52.6	-	nC
S softness fa	softness factor	0 - , - 0 ,	-	0.77	-	
			-	0.67	-	

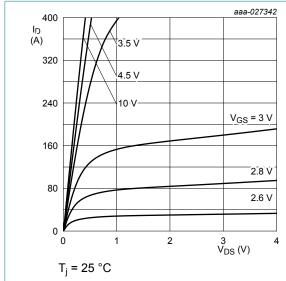


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

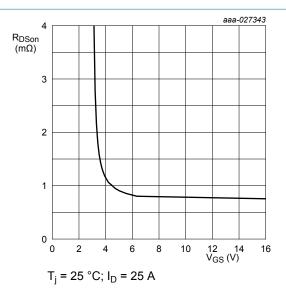


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

N-channel 40 V, 0.9 m Ω logic level MOSFET in LFPAK56E

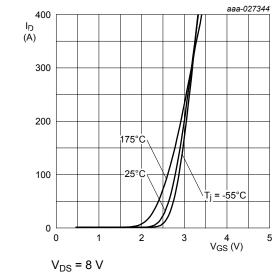


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values

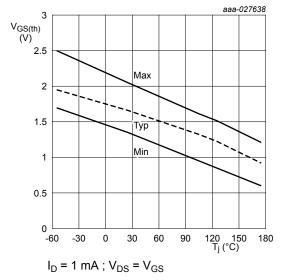


Fig. 10. Gate-source threshold voltage as a function of junction temperature

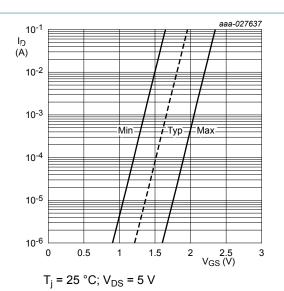


Fig. 9. Sub-threshold drain current as a function of gate-source voltage

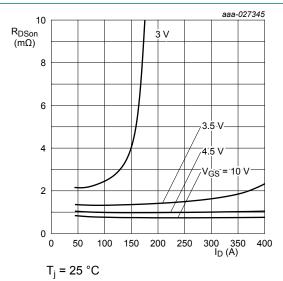


Fig. 11. Drain-source on-state resistance as a function of drain current; typical values

N-channel 40 V, 0.9 mΩ logic level MOSFET in LFPAK56E

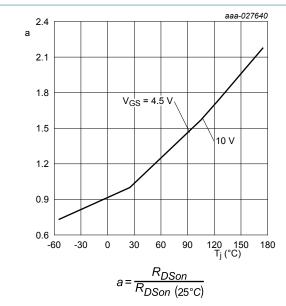


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature

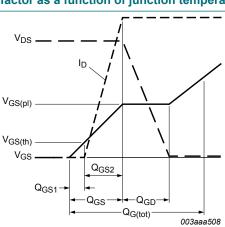


Fig. 14. Gate charge waveform definitions

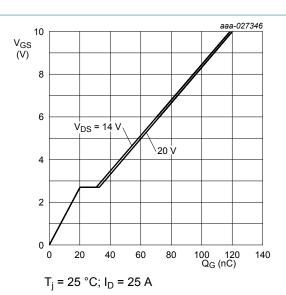


Fig. 13. Gate-source voltage as a function of gate charge; typical values

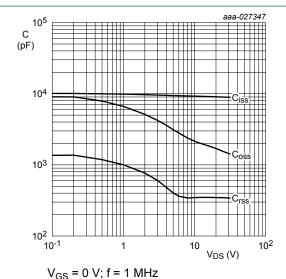


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

N-channel 40 V, 0.9 m Ω logic level MOSFET in LFPAK56E

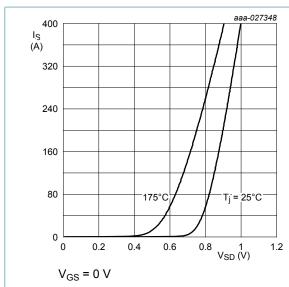


Fig. 16. Source-drain (diode forward) current as a function of source-drain (diode forward) voltage; typical values

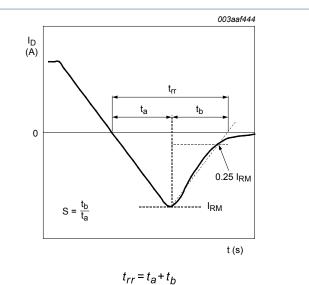
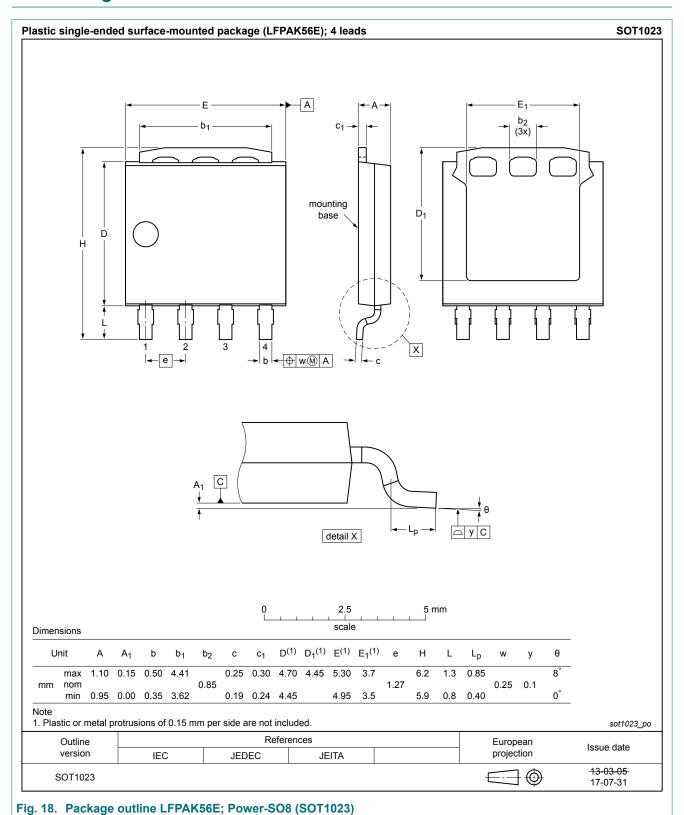


Fig. 17. Reverse recovery waveform definitions

11. Package outline



N-channel 40 V, 0.9 mΩ logic level MOSFET in LFPAK56E

12. Legal information

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Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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N-channel 40 V, 0.9 m Ω logic level MOSFET in LFPAK56E

Contents

1.	General description	1
2.	Features and benefits	1
3.	Applications	1
4.	Quick reference data	1
5.	Pinning information	2
6.	Ordering information	2
7.	Marking	2
8.	Limiting values	3
9.	Thermal characteristics	5
10	Characteristics	6
11.	Package outline	11
12	Legal information	.12

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